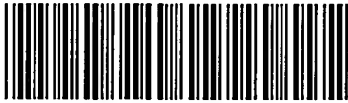


**Search Notes**

Application/Control No.

10/764,854

Examiner

David E. Martinez

Applicant(s)/Patent under  
Reexamination

OKMIANSKI ET AL.

Art Unit

2181

**SEARCHED**

Class	Subclass	Date	Examiner

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
710	52,57,29	8/28/2006	DM
710	35	8/28/2006	DM
711	135	8/28/2006	DM
Databases: US Patents, US PGPUBS, USOCR, EPO, JPO, Derwent,		8/28/2006	DM

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East see attached	8/28/2006	DM
710/15,18,29,30,33-35,52,57.ccls. 709/223-226.ccls. 711/135.ccls. with keywords and text search	8/28/2006	DM
Databases: US Patents, US PGPUBS, USOCR, EPO, JPO, Derwent, IBM_TDB.	8/28/2006	DM
Niketa Palel	8/28/2006	DM